#6/a 8/17/00 Surler

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventors:

Hausmann, et. al.

Title:

WAVE FIELD MICROSCOPE, METHOD FOR A WAVE FIELD

MICROSCOPE, INCLUDING FOR DNA SEQUENCING, AND

CALIBRATION METHOD FOR WAVE FIELD MICROSCOPY

Filing Date:

Herewith, National Phase of WO 99/02974, filed July 9, 1998

Art Unit:

Not yet known

Examiner:

Not yet known

Assistant Commissioner for Patents Washington, D.C. 20231

Dear Sir:

PRELIMINARY AMENDMENT

Please amend the above-identified application before a first office action on the merits as follows:

IN THE SPECIFICATION

On page 1, before line 1, change "Specification" to -- BACKGROUND OF THE INVENTION--.

On page 1, line 2, change "system, which includes at least one" to -system.

On page 1, delete lines 3-17.

On page 4, line 31, insert - which is not necessarily prior art to the present

application -- after "method." Q1

On page 15, before line 15, insert -- SUMMARY OF THE INVENTION--.

On page 27, before line 26, insert -- DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS--.